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Cite this: DOI: 10.1039/c0xx00000x

ARTICLE TYPE

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## Graphene oxide as dual functional interface modifier for improving wettability and retarding recombination in hybrid perovskite solar cells

Wenzhe Li, Haopeng Dong, Xudong Guo, Nan Li, Jiangwei Li, Guangda Niu, Liduo Wang\*

Received (in XXX, XXX) XthXXXXXXXXXX 20XX, Accepted Xth XXXXXXXXXXXXX 20XX

DOI: 10.1039/b000000x

The interface between perovskite and the hole transport layer (HTL) is very sensitive to photoelectric conversion properties. However, this study shows that the interface wettability of the HTL solution on a perovskite surface is not excellent. To address this problem, graphene oxide (GO) with amphiphilic function is used to form a buffer layer between the perovskite and the HTL. After the GO modification, the contact angles of the HTL solution on the perovskite film is decreased to zero degrees. X-ray photoelectron spectroscopy reveals that the GO interacts with the perovskite by forming Pb-O bonds, and Raman spectroscopy analysis reveals that the two-dimensional carbon-carbon bonds absorb the hole transport material, 2,29,7,79-tetrakis-(N,N-di-p-methoxyphenyl-amine)-9,99-spirobifluorene (Spiro-MeOTAD) via  $\pi$ - $\pi$  interactions. The GO layer improves the contact between the perovskite and HTL, resulting in an enhancement of the short circuit current ( $J_{SC}$ ). Moreover, using GO as an insulating buffer layer can retard charge recombination in solar cells revealed by EIS measured in dark conditions, leading to a significant increase of in the open-circuit voltage ( $V_{OC}$ ) and the fill factor ( $FF$ ). Consequently, the corresponding average efficiency greatly increases by 45.5%, from 10.0% to 14.5%. Therefore, the application of GO as a dual-functional buffer layer on the perovskite layer is a useful strategy for preparing highly efficient hybrid perovskite solar cells.

### 1 Introduction

Organic-inorganic hybrid materials, such as perovskite  $\text{CH}_3\text{NH}_3\text{PbI}_3$ , have been used as light harvesters for solar cells owing to their multiple capabilities of light absorption, charge separation, and transport of both holes and electrons.<sup>1-7</sup> The additional advantages of low cost, easy fabrication, and high efficiency make solar cells based upon this type of material potentially ideal photoelectric devices.<sup>1, 8</sup> Up to this point, the efficiency of lead halide perovskite ( $\text{CH}_3\text{NH}_3\text{PbX}_3$ , X = Cl, Br, I)-based photovoltaic devices has taken a huge leap forward from 3.8% to more than 19% in just 5 years.<sup>7, 9, 10</sup> Compared with vacuum deposition<sup>4</sup> and vapor-assisted solution processing,<sup>11</sup> the sequential deposition method has the advantages of easy control and good repeatability, and can improve the loading of  $\text{PbI}_2$  with a  $\text{PbI}_2/\text{N,N}$ -dimethylformamide (DMF) solution. In this way, more densely packed and smooth  $\text{CH}_3\text{NH}_3\text{PbI}_3$  crystals on  $\text{TiO}_2$  films have been obtained,<sup>12</sup> as well as the highest process cycle efficiency (PCE) of as-prepared dye-sensitized solar cells (up to 15%), with a long-term stability maintaining 80% of the initial PCE after 500 h.<sup>6</sup> The hole transport material (HTM) 2,29,7,79-tetrakis-(N,N-di-p-methoxyphenyl-amine)-9,99-spirobifluorene

(Spiro-MeOTAD) has commonly been used, with 4-tert-butylpyridine (TBP) and bis(trifluoromethane)sulfonimide lithium salt (Li-TFSI) as additives.<sup>13</sup>

Graphene oxide (GO) is a precursor for graphene synthesis by either chemical or thermal reduction methods.<sup>14, 15</sup> Graphene oxide has been attracting a great deal of attention because of its reliability and low production costs, large-scale production capability, and good dispersability in many solvents.<sup>16-18</sup> With respect to structure, GO presents a two-dimensional carbon-carbon structure that encompasses various oxygen-containing functional groups, mostly in the form of carboxyl, carbonyl, phenol, lactone, and quinone typically at the sheet edges.<sup>14, 19</sup> This structure provides flexibility for guiding the modification of GO sheets via covalent functionalization.<sup>18</sup> In this way, the hydrophilic edges and hydrophobic centers of the GO sheets cause them to act as surfactants.<sup>20</sup> However, the oxygen functional groups in GO create structural inhomogeneities, including reduced electron mobility, which make it a potential material in perovskite solar cells for retarding electron recombination, and give it the potential to be different from the materials we have previously explored for interface engineering, such as  $\text{Al}_2\text{O}_3$ ,<sup>21, 22</sup> and montmorillonite (MMT).<sup>23</sup>

Herein, we demonstrate that the interface between the HTL

solution and perovskite cannot have perfect wettability, but that GO as an amphiphilic functional layer treating the perovskite surface decreases the contact angles (CAs) to zero degrees. The reaction of the GO to perovskite is studied by X-ray photoelectron spectroscopy (XPS), and the reaction of GO to spiro-MeOTAD in the HTL is investigated by infrared (IR) and Raman spectra. The PCE of the fabricated devices treated with GO is significantly enhanced. Electrochemical impedance spectroscopy (EIS) measurements in sunlight reveal a decrease in the forward transport resistance, which enhances wettability, and the increase of the charge collection efficiency results in higher short circuit current ( $J_{SC}$ ) values. The EIS measurements in the dark are used to study the behavior of electron recombination at the  $\text{TiO}_2$ /sensitizer/HTL interface to examine the increase in the open-circuit voltage ( $V_{OC}$ ) and the fill factor ( $FF$ ) in the photocurrent–voltage ( $J$ – $V$ ) curves.

## 2 Experimental section

**2.1 Solar cell fabrication and GO treatment.** The  $\text{TiO}_2$  compact layers were deposited on fluorine-doped tin oxide glass using atomic layer deposition (Beneq TFS 200). Titanium dioxide ( $\text{TiO}_2$ ) was deposited at  $150^\circ\text{C}$  using titanium tetrachloride ( $\text{TiCl}_4$ ) and  $\text{H}_2\text{O}$  as Ti and O precursors, respectively, and was deposited in pulse mode in a nitrogen flow of 300 sccm. The  $\text{TiCl}_4$  was retained in the chamber for 0.25 s, and subsequently the  $\text{H}_2\text{O}$  was retained for 0.25 s. The wait period for both precursors was 1 s. At  $150^\circ\text{C}$ , the  $\text{TiO}_2$  growth rate per cycle was  $0.5 \text{ \AA}$ , and the  $\text{TiO}_2$  deposition was performed for 300 cycles to achieve a layer thickness of 17 nm. The nanocrystalline  $\text{TiO}_2$  paste (18NRT from Dyesol Company; diluted to w/w 33%) was deposited on the pre-treated fluorine-doped tin oxide substrate at 7000 rpm for 30 s, followed by heating at  $500^\circ\text{C}$  for 1 h. The thickness of the annealed  $\text{TiO}_2$  films was nearly 350 nm, as determined by scanning electron microscopy (SEM; JEOL JSM-7401F). The perovskite preparation process followed Ref. [6]. The DMF (Aldrich, 99.9%) solution (462 mg/mL) containing  $\text{PbI}_2$  (Aldrich, 99.9985%) was heated to  $60^\circ\text{C}$  under magnetic stirring overnight, whereupon the mixture was spin coated on the as-prepared  $\text{TiO}_2$  film at 6500 rpm for 90 s in a glove box. The films were then dried at  $70^\circ\text{C}$  for 30 min and were dipped in a solution of  $\text{CH}_3\text{NH}_3\text{I}$  in 2-propanol (10 mg/mL) for 120 s and then rinsed with 2-propanol. The films were dried at  $70^\circ\text{C}$  for 30 min, after which the color of the films was dark red. The GO (JCGO-99-1-100n; JCNANO company) dispersion was prepared by mixing 3 mg of GO powder with 1 mL chlorobenzene, was mixed via shake for 2 min and filtrated with a 220-nm filter. The final concentration of the solution was 340 mg/L at full dilution. After perovskite annealing process, diluted GO dispersion (85 mg/L) was dripped on perovskite film followed by 30 s infiltration. And then it was spin coated at 7000 rpm for 30 s. The control sample is treated by chlorobenzene in the same process. 30 min later, the  $\text{CH}_3\text{NH}_3\text{PbI}_3$ -coated  $\text{TiO}_2$  films were covered with the HTM solution using spin coating at 4000 rpm for 30 s. The HTM composition was 73 mg of spiro-MeOTAD, 9.1 mg of Li-TFSI, and 37.5  $\mu\text{L}$  of TBP (96%, Aldrich) in a solvent consisting of 1 mL of chlorobenzene (99.8% SuperDry, J&K Scientific). For the counter electrode, a 60-nm-thick film of Au was deposited on top of the HTL overlayer by thermal evaporation.

**2.2 Characterization.** Ultraviolet-visible light absorption spectra were employed to assess the absorption properties of the perovskite-sensitized  $\text{TiO}_2$  film with a Hitachi U-3010 spectroscope. The CAs were measured with an optical CA meter (OCA20, Dataphysics) at room temperature. The Raman spectra were collected using a Raman spectrometer (Renishaw) with a 514-nm laser, and XPS was measured with a PHI 5300 ESCA Perkin-Elmer spectrometer. The topographical and potential phase maps were measured under ambient air with a Kelvin probe force microscope (Seiko instrument SPA 400). The Fourier transform infrared (FTIR) spectrum was measured with a Perkin-Elmer Spectrum GX FTIR spectrometer. The photocurrent–voltage ( $J$ – $V$ ), incident photon-to-electron conversion efficiency (IPCE), and the electrochemical impedance spectra (EIS; from 0.1 to  $10^5$  Hz) were measured by an electrochemical workstation (ZAHNER CIMPS, Germany) under a solar simulator (Xenon lamp, Oriel, AM 1.5,  $100 \text{ mW cm}^{-2}$ ). The mask active area was fixed at  $0.09 \text{ cm}^2$ .

## 3 Results and discussion

### 3.1 GO influence on the interface wettability between HTL solution/perovskite

At the perovskite and HTL interface, the HTL solution, including spiro-MeOTAD, Li-TFSI, TBP, and chlorobenzene, cannot immediately spread out, and the CAs of the HTL solution directly upon the perovskite film are measured and found to be  $13.4^\circ$  (Fig. 1a). The perovskite  $\text{CH}_3\text{NH}_3\text{PbI}_3$  material has a strong polarity, while the HTL containing the chlorobenzene solvent has a weaker polarity. The CAs are determined on substrates of different polarities and roughness,<sup>24</sup> but the perovskite surface is unfortunately quite rough, with a calculated root mean square roughness value of  $44.3 \text{ nm}$ .<sup>25</sup> Additionally, the TBP in the HTL is helpful in reducing the surface tension, though our previous studies have found that TBP in the HTL can corrode and fade the perovskite films. To improve the HTL solution wettability, a type of lamellar surfactant is needed to enhance the interface contact between the perovskite and HTL. Graphene oxide is an amphiphilic material, where the main surface of the sheet contains polyaromatic rings and the edge of the sheet concentrates oxygen atoms into carboxylic acid groups.<sup>26</sup> Therefore, a monolayer GO sheet dispersed in chlorobenzene is spin coated onto the perovskite and the HTL solution is subsequently dropped onto this modified surface, whereupon the contact angle decreases to zero degrees. Consequently, the GO on

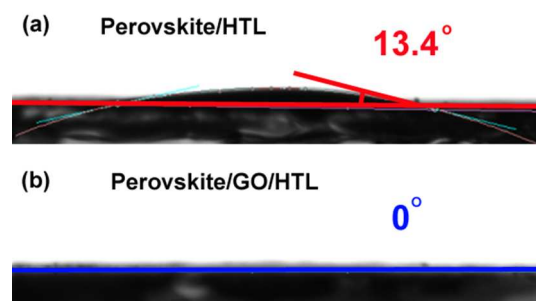


Fig. 1. HTL solution contact angles of perovskite films w/o and with GO modification on a FTO substrate



the perovskite effectively improves the ability of the HTL to spread which would benefit the contact between perovskite and HTL.

### 3.2 The interaction between GO and perovskite/HTL

#### 3.2.1 The interaction between GO and perovskite

The XPS spectra of the signals for I 3d, O 1s, C 1s, and Pb 4f are collected from the perovskite films, GO powders, and GO-modified perovskite films to probe the chemical environment of the elements in the near-surface range (Fig. 2a). The perovskite films without and with GO modification exhibit an increased atomic ratio of Pb:C:O, increasing from 1:1.78:0.39 to 1:5.57:1.64, respectively. Because GO is composed mainly of C and O, the increase in the C and O content is owing to the GO present on perovskite. As indicated in Fig. 2b, the asymmetric and broad features of the observed C 1s peaks suggest the co-existence of distinguishable models. In the perovskite spectra, the main peak located at 286.13 eV is attributed to the C–N binding energy. Deconvolution core level spectra at 284.84, 286.87, and 288.74 eV are in agreement with the GO data.<sup>27</sup> The sharp peak located at 284.84 eV is attributed to sp<sup>2</sup> hybridized carbon atoms,<sup>28</sup> the peak at 286.87 eV is ascribed to the existence of C–OH bonds,<sup>29</sup> and the weak peak at 288.74 eV is ascribed to the

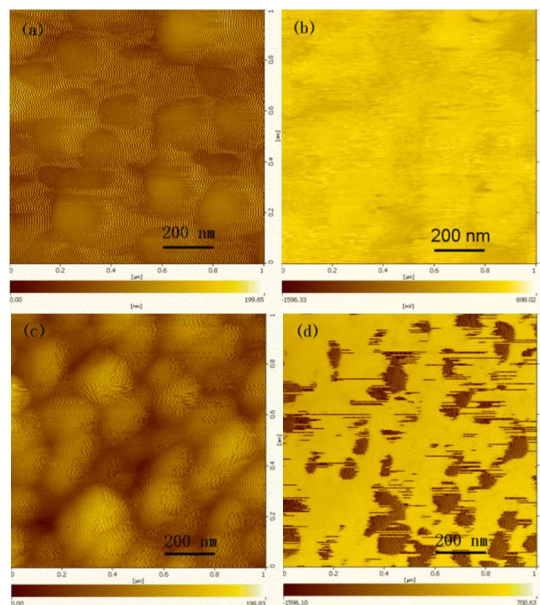


Fig. 3. KPFM images of (a) TOPO phase and (b) potential phase of Si slice covered by perovskite, (c) TOPO phase and (d) potential phase of Si slice covered by perovskite with GO.

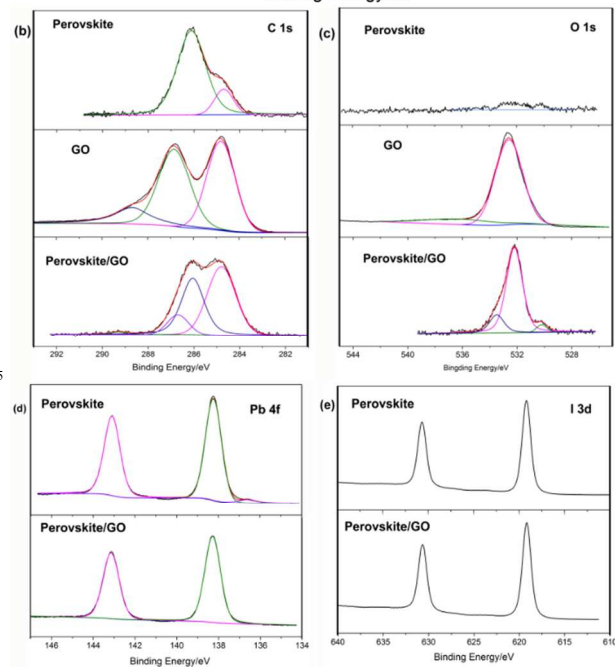
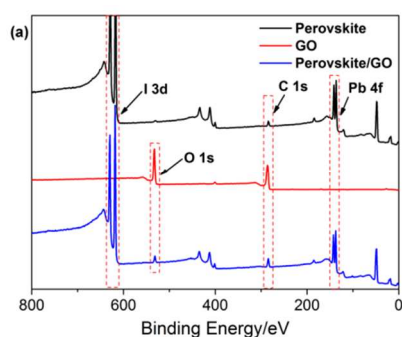


Fig. 2. The overview (a) and the corresponding high-resolution XPS spectra (b) C 1s, (c) O 1s, (d) Pb 4f, and (e) I 3d of the as-prepared perovskite films, GO powder and GO modified perovskite films.

existence of C–OOH bonds.<sup>30</sup> Compared with the spectra of unmodified films, the intensity of the peak at 284.82 eV improves significantly for GO-modified perovskite films, and the content ratio of the C–C to C–N bonds increases from 0.18 to 1.00 when the GO surface is modified. Fig. 2c shows the high-resolution spectra of O 1s. In the case of the perovskite films, the curve fitting of the O 1s spectrum basically indicates a trace amount of the O element. For GO powders, the O 1s spectra indicate two components centered at 532.62 and 535.74 eV, which are commonly ascribed to the surface oxygen complexes of the carbon phase.<sup>31, 32</sup> For the GO-modified film, the three peaks at 533.48, 532.27, and 530.4 eV clearly improve, where the peak at 533.48 eV is ascribed to absorbed water vapor,<sup>33</sup> the peak with higher intensity at 532.27 eV is attributed to organic oxide contribution. The lead–oxygen bonds in pure PbO are located at 528.9 eV,<sup>34</sup> but when the carboxyl groups connect with organic groups, such as the O in GO, the peak shifts to higher binding energies because of the electron distinct effect.<sup>35</sup> Therefore, the strength increase of the peak at 530.4 eV is most likely owing to the creation of Pb–O bonds.

The high-resolution spectra of Pb 4f are shown in Fig. 2d, which is proved that the GO decrease the defects in perovskite. In the perovskite case, the relatively weak peak is at 136.74 eV, and is associated with Pb possessing a low state of unsaturated atoms.<sup>36</sup> The reason for unsaturated Pb atoms in perovskite is I atoms vacancy. The vacancy leads to the ionization of the point defects, which is of importance for surpassing charge transport and creating luminescent centers.<sup>37, 38</sup> The ref. report the defects can be surpassed by iodopentafluorobenzene<sup>39</sup>, thiophene and pyridine<sup>40</sup>. In one aspect, the defects in crystal affect the charge separating and transport. On the other, the defects in the crystal state decrease the thermodynamic stability. After GO surface modification, the ratio of the areas of the peaks at 136.74 and 138.22 eV decreases from  $6.79 \times 10^{-2}$  to  $3.57 \times 10^{-2}$ . Combining this result with the information from the O 1s curves, it is evident that part of the O atoms in the GO connect with unsaturated Pb atoms in the perovskite, surpassing the surface defect states.

75 Kelvin probe force microscopy is used to detect the potential

difference of a perovskite surface prepared on a silicon base. Fig. 3 reveals the topographical and potential phase of the samples with and without GO dispersions. The oxygen functional groups in GO create structural inhomogeneities, including reduced electron mobility.<sup>41, 42</sup> Fig. 3b and 3d shows that the potential differences at the perovskite surface significantly increase when GO is added, where the regions in Fig. 3d with dark colors correspond to regions of lower potential covered by GO sheets. Furthermore, the dispersion and morphology of these regions of lower potential closely follow the GO area size of approximately 150 nm. These results together with the XPS results lead us to conclude that GO partially cover the perovskite.

### 3.2.2 The interaction between GO and HTL

To confirm the reaction between GO and the HTM Spiro-MeOTAD, 2 mg of Spiro-MeOTAD is mixed with 5 mg of GO powder in chlorobenzene and the mixture is centrifuged and dispersed for five cycles to remove free Spiro-MeOTAD. After vacuum drying at 60°C for 24 h, brown-colored powders are obtained. The IR spectra obtained from the GO powders and the Spiro-MeOTAD-treated GO powders are shown in Fig. 4a. It is clear that there is improvement in the absorbance in the range of 500–2000 cm<sup>-1</sup> after Spiro-MeOTAD treatment. The peaks at 1602, 1498, 1466, and 1248 cm<sup>-1</sup> especially indicate the absorption of methoxy phenyl, which connect to the molecular periphery of Spiro-MeOTAD, and the GO performs as a base absorbing the Spiro-MeOTAD onto its surface.

The chemical reaction of GO with Spiro-MeOTAD is further supported by the Raman spectra shown in Fig. 4b. The Raman spectra of the GO show two distinct and broad peaks at 1350 and 1580 cm<sup>-1</sup>. The peak at 1350 cm<sup>-1</sup> is usually associated with the sp<sup>3</sup> bonding in GO, while the peak at 1580 cm<sup>-1</sup> is usually related to the sp<sup>2</sup> bonding, and both are recognized as I<sub>D</sub> and I<sub>G</sub>, respectively. The curves show a slight decrease in the ratio of the I<sub>D</sub> to I<sub>G</sub> band intensity from 0.99 to 0.94 after Spiro-MeOTAD treatment. This may be because of the increased influence of the π-π interaction on the molecule, which thereby enhances the interactions between the GO layers and the Spiro-MeOTAD molecule and decreases the distortion of the GO.

### 3.3 Photovoltage performance of perovskite solar cells after adding GO as a buffer

Solid-state perovskite solar cells are fabricated using the GO as a buffer between the perovskite absorption layer and the HTL, and the subsequent enhancement of the device conversion efficiency is investigated. The *J-V* curves were measured with either a 0.2 s delay after each 10 mV voltage step (50 mV/s). The scans carried out in negative directions from 1.1 V to 0 V followed the method ref<sup>43</sup> provided. The content of the GO dispersion is optimized from 0 to 340 mg L<sup>-1</sup>, and the *V*<sub>OC</sub>, *J*<sub>SC</sub>, *FF*, and *PCE*

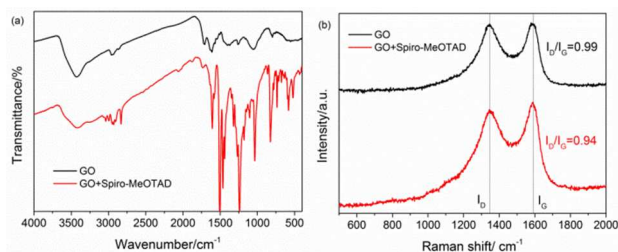


Fig. 4. (a) IR spectra and (b) Raman spectra of GO and GO/Spiro-MeOTAD samples.

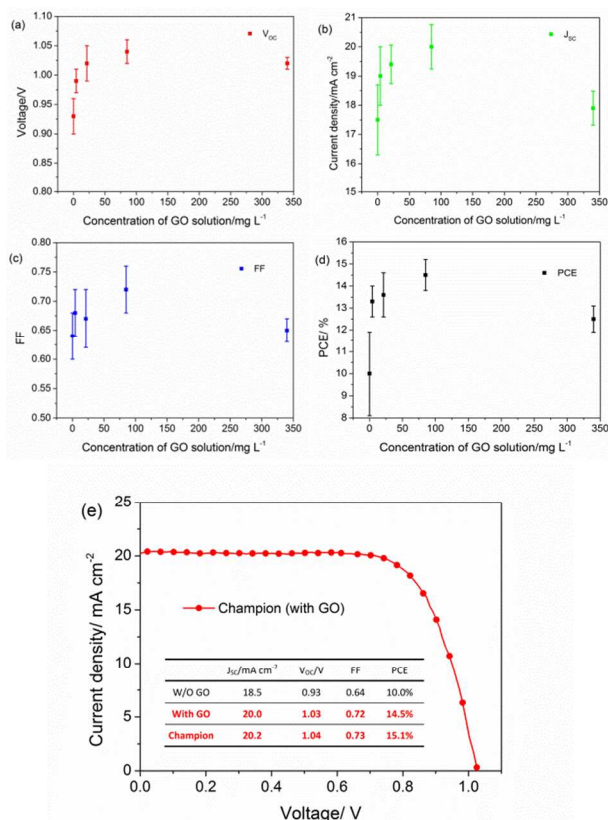


Fig. 5. (a) *V*<sub>OC</sub>, (b) *J*<sub>SC</sub>, (c) *FF* and (d) *PCE* data followed the content of GO dispersion from 0 to 340 mg L<sup>-1</sup>. The *J-V* characteristics of devices with GO addition; the inset in (e) shows the parameter of the cells.

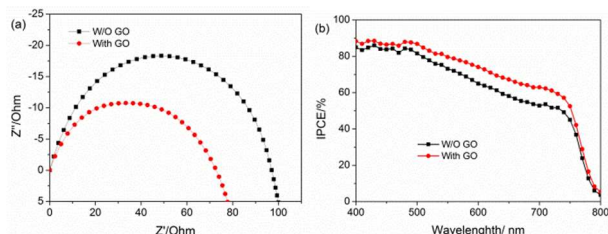


Fig. 6. (a) Nyquist plots under sun light (1.5 AM) condition (dark) without GO buffer and (red) with GO addition to the HTL and (b) IPCE curves of devices.

values via calculating 24 devices results from each GO content point are shown in Fig. 5. The results show that the optimum content of GO is 85 mg L<sup>-1</sup>, and this optimum GO content is used to cover the perovskite as a buffer layer. The device with GO performs better, with the average *PCE* increasing by 45.5% from 10.0% to 14.5%, and all of the *V*<sub>OC</sub>, *J*<sub>SC</sub> and *FF* values increasing. The champion cells for 15.1% efficiency are best performed in the 24 devices with the same preparation conditions. The addition of a GO layer before the HTL thus improves the efficiency of the perovskite-sensitized all-solid-state solar cells.

### 3.3.1 Effect on *J*<sub>SC</sub> enhancement after adding GO as a buffer.

Under full illumination, the Nyquist plot (Fig. 6a) shows the typical semicircles in a frequency range of 1–100 kHz with 0.9 V DC bias. The spectra show the first arc at high frequency and second arc with low frequency is not given. Because the GO sheet could enhance the contact between perovskite and HTL as previous discussed. The first arc is related to selective contact<sup>44, 45</sup> which is decreased with GO addition. The electron-selective



contact is not changed. Therefore, the hole-selective contact enhances with GO addition. This may be owing to the improvement of the interface wettability by the GO layer, which is supported by the contact angle results, and reducing the gap between the rough perovskite and the HTL. The improved contact in the post-perovskite interface can also increase the  $FF$  in device performance.<sup>46</sup>

Monochromatic, incident photon-to-electron conversion efficiency (IPCE) of the device maintains a similar magnitude for the wavelength range of 400–800 nm, matching the absorbance range of perovskite. The IPCE can be expressed by<sup>47</sup>

$$IPCE(\lambda) = LHE(\lambda) \cdot \Phi_{inj} \cdot \eta_c \quad (1)$$

where  $LHE$  is the light-harvesting efficiency,  $\phi_{inj}$  is the quantum yield of electron injection from the excited sensitizer into the  $TiO_2$  conduction band, and  $\eta_c$  is the collection efficiency of the photo-generated charge carriers. We examine separately the three efficiency parameters in Eq. (1) to elucidate the reasons for the higher IPCE values. The light absorption of the  $TiO_2$ /perovskite film, which is related to the LHE value, slightly increases with the addition of GO (Fig. S1). However, the large IPCE value enhancements, such as the 20.1% enhancement at the 700 nm wavelength, suggest that there are further influences upon the IPCE values. The  $\eta_c$  is determined by the process of electron collection from  $TiO_2$  to FTO and hole collection from hole transporter to Au counter electrode. The process is not related to GO addition in interface between perovskite and HTL. The  $\phi_{inj}$  is determined not only by the process of electron injection from perovskite excited state to  $TiO_2$  CB, but also the hole injection to hole transporter. The GO addition is not influence the electron injection, but the hole injection. The GO enhances the hole-selective contact. Therefore, the hole injection process is improved resulting the enhancement of IPCE and current density.

### 3.3.2 Effect on recombination retardation after adding GO

In this study, we notice that GO not only forms an active surface layer connecting the perovskite and HTL, thereby enhancing hole-selective contact, but it also retards the charge recombination occurring at the  $TiO_2$  interface. What is actually happening is that the oxygen functional groups in GO break the homogeneities of the graphene, causing a reduced electron mobility.<sup>41, 42</sup> Therefore, GO as an insulator<sup>48</sup> and defects surpass agent may function to retard the electron recombination at the post-surface of perovskite and HTL. The Nyquist plot of the impedance spectra acquired in dark condition, the spectra are obtained for 0.9 V DC bias in a frequency range of 0.1–100 kHz. (Fig. 7a). In the equivalent circuit model,  $R_1$  is related to recombination resistance and  $CPE_1$  is the chemical capacitance of the film;  $R_2$  and  $CPE_2$  is related to HTM resistance, capacitance and the extraction in the Au electrode. The first arc at higher frequencies, is related to the

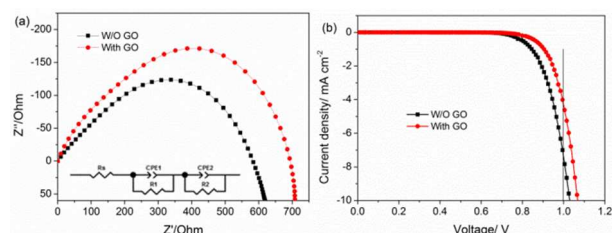


Fig. 7 (a) Nyquist plots under dark condition with 0.9 V bias voltage, (b) under sun light (1.5 AM) condition and (c) the dark current curves

HTM transport and extraction in the Au electrode. The main arc is due to the combination of the recombination resistance ( $R_2$ ) and the chemical capacitance of the film ( $CPE_2$ ).<sup>45, 49-51</sup> The  $R_1$  values change from 596  $\Omega$  without GO to 784  $\Omega$  with GO, corresponding to a 31.5% increase. The recombination resistance increase may be owing to introducing insulator at interface and surpassing perovskite surface defects. Generally, an increased resistance in dark conditions indicates a restrained charge recombination. In our case, this was verified by the dark current measurement where the  $J$ - $V$  curve is recorded from the fabricated device being measured in the dark. As shown in Fig. 6c, there is 1.8 times the amount of dark current found in the unmodified device than in the modified one, for example at  $V_{OC}=1.0$  V.

Changes in the  $V_{OC}$  can reveal the extent of delayed electron recombination, so we determine  $V_{OC}$  using the formula<sup>52</sup>

$$V_{OC} = \left(\frac{mRT}{F}\right) \ln\left(\frac{I_{SC}}{I_0} - 1\right) \quad (3)$$

where  $I_{SC}$  is the short-circuit photocurrent,  $I_0$  is the dark current,  $m$  is the ideality factor whose value is between 1 and 2 for perovskite solar cells, and  $R$  and  $F$  are the ideal gas and Faraday constants, respectively. According to the Eq. (3),  $V_{OC}$  increases with decreasing  $I_0$ . Theoretically, the extent of the delayed charge recombination also improves the  $FF$  values, which can be determined from the  $J$ - $V$  plot analysis, and is consistent with our results.

## 4 Conclusions

We find an efficient method using GO as an amphiphilic modifier to enhance the interface contact between perovskite and the HTL to improve the photovoltaic performance of perovskite-sensitized solar cells. After the GO interface treatment, the HTL contact angles on the perovskite films decrease from 13.4 to 0.0 degrees. The interaction between GO and perovskite and HTL is studied to ensure the amphiphilic function. The XPS results reveal that GO interacts with the perovskite by forming Pb–O bonding, which surpasses the unsaturated Pb bond on the surface. Raman spectroscopy analysis reveals that the two-dimensional carbon-carbon bonds absorb spiro-MeOTAD by a  $\pi$ - $\pi$  interaction. The corresponding efficiency of the device is improved by 45.5%, and an overall efficiency of 15.1 % is obtained under AM1.5 sunlight. An increase in  $J_{SC}$  is attributed to an enhanced charge collection efficiency resulting from improved contact between the perovskite and HTL. The enhancement of  $V_{OC}$  and especially for the  $FF$  benefits from a restrained charge recombination. This is evidenced by the EIS measured in dark conditions, where the recombination resistance in the dark is increased. This work therefore supplies a useful strategy to enhance the efficiency of all-solid-state perovskite solar cells.

## Acknowledgements

This work is supported by the National Natural Science Foundation of China under Grant no. 51273104.

## Notes and references

Key Lab of Organic Optoelectronics & Molecular Engineering of Ministry of Education, Department of Chemistry, Tsinghua University, Beijing 100084, China  
E-mail: chldwang@mail.tsinghua.edu.cn

Tel: (008610) 62788802, Fax: (008610) 62795137

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## Supporting Information

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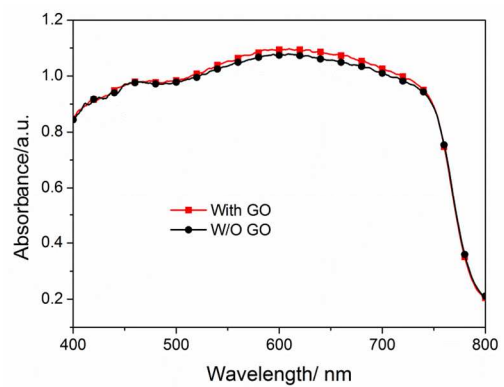
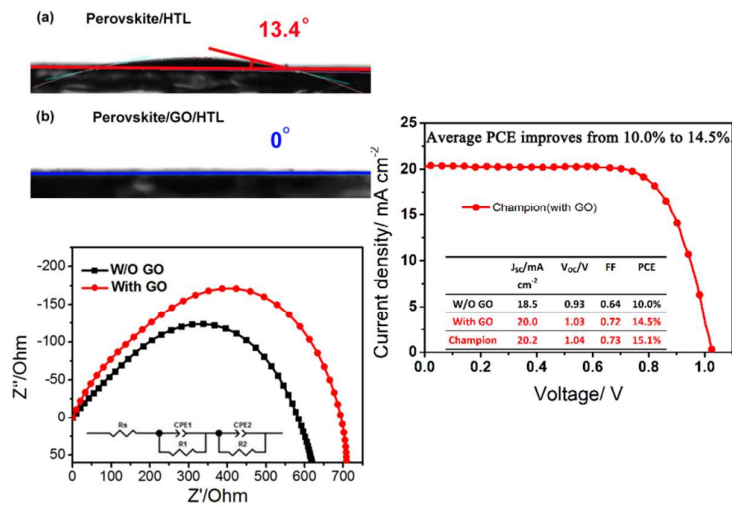


Fig. S3. UV-vis absorption of TiO<sub>2</sub>/perovskite films without GO treatment (black line) and with GO treatment (red line).

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## TOC



The GO as an amphiphilic modifier enhances the selective contact between perovskite and the HTL to improve the photovoltaic performance of perovskite-sensitized solar cells.